## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10562816	NAKANO ET AL.
Examiner	Art Unit
SHIN-HON CHEN	2431

SEARCHED				
Class	Subclass	Date	Examiner	
713	175 176 156-158	3/17/09	SC	

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search )	3/17/09	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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